



CERTIFICATE OF ACCREDITATION

ANSI-ASQ National Accreditation Board

500 Montgomery Street, Suite 625, Alexandria, VA 22314, 877-344-3044

This is to certify that

Trident Calibration Labs
2340 W. Parkside Lane, Suite H-105
Phoenix AZ 85027

has been assessed by ANAB
and meets the requirements of international standard

ISO/IEC 17025:2005

and national standard

ANSI/NCSL Z540-1-1994 (R2002)

while demonstrating technical competence in the field of

CALIBRATION

Refer to the accompanying Scope of Accreditation for information regarding the types of calibrations to which this accreditation applies.

AC-1986

Certificate Number


ANAB Approval

Certificate Valid: 07/06/2018-09/11/2019
Version No. 005 Issued: 07/06/2018



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



**SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005,
ANSI/NCSL Z540-1-1994 (R2002)**

Trident Calibration Labs

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CALIBRATION

Valid to: **September 11, 2019**

Certificate Number: **AC-1986**

Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC Voltage - Source	Up to 220 mV	7 nV/mV + 0.6 μ V	Fluke 5700A Multiproduct Calibrator
	220 mV to 2.2 V	6.24 μ V/V + 1 μ V	
	(2.2 to 11) V	6.3 μ V/V + 3.5 μ V	
	(11 to 22) V	6.2 μ V/V + 6.5 μ V	
	(22 to 220) V	7 μ V/V + 80 μ V	
DC Voltage - Measure	220 V to 1.1 kV	8.7 μ V/V + 0.5 mV	Fluke 8508A Multimeter
	Up to 100 mV	4.7 nV/ μ V + 0.1 μ V	
	100 mV to 1 V	2.5 μ V/V + 0.4 μ V	
	(1 to 10) V	2.4 μ V/V + 0.4 μ V	
	(10 to 100) V	3.8 μ V/V + 40 μ V	
DC Current - Source	100 V to 1 kV	3.8 μ V/V + 0.5 mV	Vitretek 4700
	(1 to 10) kV	0.05 % of reading	
DC Current - Source	Up to 220 μ A	0.04 nA/ μ A + 5.43 nA	Fluke 5700A Multiproduct Calibrator
	220 μ A to 2.2 mA	33 nA/mA + 6.2 nA	
	(2.2 to 22) mA	32 nA/mA + 39 nA	
	(22 to 220) mA	41 nA/mA + 0.62 nA	
	220 mA to 2.2 A	91 μ A/A + 12 μ A	
DC Current - Source	(2.2 to 11) A	0.42 mA/A + 0.39 mA	Fluke 5522A/SC1100 Multiproduct Calibrator
	(11 to 20.5) A	0.86 mA/A + 0.58 mA	



Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC Current - Measure	(0 to 200) μ A (0.2 to 2) mA (2 to 20) mA (20 to 200) mA (0.2 to 2) A (2 to 20) A	13 μ A/A + 0.4 nA 14 μ A/A + 4 nA 14 μ A/A + 40 nA 48 μ A/A + 0.8 μ A 0.18 mA/A + 16 μ A 0.41 mA/A + 0.4 mA	Fluke 8508A Multimeter
DC Resistance - Source	Up to 11 Ω (11 to 33) Ω (33 to 110) Ω (110 to 330) Ω 330 Ω to 1.1 k Ω (1.1 to 3.3) k Ω (3.3 to 11) k Ω (11 to 33) k Ω (33 to 110) k Ω (110 to 330) k Ω 330 k Ω to 1.1 M Ω (1.1 to 3.3) M Ω (3.3 to 11) M Ω (11 to 33) M Ω (33 to 110) M Ω (110 to 330) M Ω (330 to 1 100) M Ω	38 $\mu\Omega/\Omega$ + 0.78 m Ω 25 $\mu\Omega/\Omega$ + 1.2 m Ω 23 $\mu\Omega/\Omega$ + 1.1 m Ω 22 $\mu\Omega/\Omega$ + 1.6 m Ω 22 m $\Omega/k\Omega$ + 1.6 m Ω 22 m $\Omega/k\Omega$ + 16 m Ω 22 m $\Omega/k\Omega$ + 16 m Ω 22 m $\Omega/k\Omega$ + 0.16 Ω 22 m $\Omega/k\Omega$ + 0.16 Ω 25 m $\Omega/k\Omega$ + 1.6 Ω 26 $\Omega/M\Omega$ + 1.6 Ω 48 $\Omega/M\Omega$ + 23 Ω 0.1 k $\Omega/M\Omega$ + 39 Ω 0.22 k $\Omega/M\Omega$ + 1.9 k Ω 0.45 k $\Omega/M\Omega$ + 2.3 k Ω 2.3 k $\Omega/M\Omega$ + 78 k Ω 12 k $\Omega/M\Omega$ + 0.39 M Ω	Fluke 5522A/SC1100 Multiproduct Calibrator
DC Resistance Fixed Points	1 Ω 1.9 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1 k Ω 1.9 k Ω 10 k Ω 19 k Ω 100 k Ω 190 k Ω 1 M Ω 1.9 M Ω 10 M Ω 19 M Ω 100 M Ω	97 $\mu\Omega/\Omega$ 97 $\mu\Omega/\Omega$ 30 $\mu\Omega/\Omega$ 29 $\mu\Omega/\Omega$ 19 $\mu\Omega/\Omega$ 19 $\mu\Omega/\Omega$ 16 $\mu\Omega/\Omega$ 16 $\mu\Omega/\Omega$ 9.8 $\mu\Omega/\Omega$ 9.5 $\mu\Omega/\Omega$ 9.7 $\mu\Omega/\Omega$ 9 $\mu\Omega/\Omega$ 11 $\mu\Omega/\Omega$ 14 $\mu\Omega/\Omega$ 27 $\mu\Omega/\Omega$ 0.12 m Ω/Ω 1.3 m Ω/Ω	Fluke 5700A Multiproduct Calibrator



Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
High Power Fixed Resistance	1 kΩ 10 kΩ 100 kΩ 1 MΩ 10 MΩ 100 MΩ 1 GΩ 10 GΩ 100 GΩ	5 mΩ 50 mΩ 1 Ω 10 Ω 100 Ω 2 kΩ 20 kΩ 10 MΩ 40 MΩ	IET VRS-100-9-1K-ROT Resistance Standard Set
Resistance – Measure (4 Wire Measurements)	(0 to 2) Ω (2 to 20) Ω (20 to 200) Ω (0.2 to 2) kΩ (2 to 20) kΩ (20 to 200) kΩ (0.2 to 2) MΩ (2 to 20) MΩ (20 to 200) MΩ (0.2 to 2) GΩ (2 to 20) GΩ	18 μΩ/Ω + 4 μΩ 10 μΩ/Ω + 14 μΩ 8.6 μΩ/Ω + 50 μΩ 8.6 μΩ/Ω + 0.5 mΩ 8.6 μΩ/Ω + 5 mΩ 8.6 μΩ/Ω + 50 mΩ 10 μΩ/Ω + 1 Ω 17 μΩ/Ω + 10 Ω 65 μΩ/Ω + 1 kΩ 0.18 mΩ/Ω + 0.1 MΩ 1.5 mΩ/Ω + 10 MΩ	Fluke 8508A Multimeter
AC Voltage – Source	Up to 2.2 mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz (2.2 to 22) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	1.7 μV/mV + 4.5 μV 0.8 μV/mV + 4.5 μV 0.7 μV/mV + 4.5 μV 1.3 μV/mV + 4.5 μV 1.9 μV/mV + 7 μV 3.1 μV/mV + 13 μV 4.7 μV/mV + 25 μV 5.9 μV/mV + 25 μV 0.49 μV/mV + 5 μV 0.24 μV/mV + 5 μV 0.15 μV/mV + 5 μV 0.36 μV/mV + 5 μV 0.73 μV/mV + 7 μV 1.1 μV/mV + 12 μV 1.6 μV/mV + 25 μV 3 μV/mV + 25 μV	Fluke 5700A Multiproduct Calibrator



Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source	(22 to 220) mV		Fluke 5700A Multiproduct Calibrator
	(10 to 20) Hz	0.54 $\mu\text{V/mV}$ + 13 μV	
	(20 to 40) Hz	0.17 $\mu\text{V/mV}$ + 8 μV	
	40 Hz to 20 kHz	0.09 $\mu\text{V/mV}$ + 8 μV	
	(20 to 50) kHz	0.25 $\mu\text{V/mV}$ + 8 μV	
	(50 to 100) kHz	0.67 $\mu\text{V/mV}$ + 25 μV	
	(100 to 300) kHz	0.87 $\mu\text{V/mV}$ + 25 μV	
	(300 to 500) kHz	1.4 $\mu\text{V/mV}$ + 35 μV	
	500 kHz to 1 MHz	2.7 $\mu\text{V/mV}$ + 80 μV	
	220 mV to 2.2 V		
	(10 to 20) Hz	0.61 mV/V + 80 μV	
	(20 to 40) Hz	0.13 mV/V + 25 μV	
	40 Hz to 20 kHz	61 $\mu\text{V/V}$ + 6 μV	
	(20 to 50) kHz	99 $\mu\text{V/V}$ + 16 μV	
	(50 to 100) kHz	0.21 mV/V + 70 μV	
	(100 to 300) kHz	0.36 mV/V + 0.13 mV	
	(300 to 500) kHz	0.84 mV/V + 0.35 mV	
	500 kHz to 1 MHz	1.8 mV/V + 0.85 mV	
	(2.2 to 22) V		
	(10 to 20) Hz	0.51 mV/V + 0.8 mV	
	(20 to 40) Hz	0.14 mV/V + 0.25 mV	
	40 Hz to 20 kHz	51 $\mu\text{V/V}$ + 0.06 mV	
	(20 to 50) kHz	99 $\mu\text{V/V}$ + 0.16 mV	
	(50 to 100) kHz	0.2 mV/V + 0.35 mV	
	(100 to 300) kHz	0.41 mV/V + 1.5 mV	
	(300 to 500) kHz	1 mV/V + 4.3 mV	
	500 kHz to 1 MHz	2.3 mV/V + 8.5 mV	
(22 to 220) V			
(10 to 20) Hz	0.56 mV/V + 8 mV		
(20 to 40) Hz	0.13 mV/V + 2.5 mV		
40 Hz to 20 kHz	0.066 mV/V + 0.8 mV		
(20 to 50) kHz	0.18 mV/V + 3.5 mV		
(50 to 100) kHz	0.39 mV/V + 8 mV		
(100 to 300) kHz	1.2 mV/V + 90 mV		
220 V to 1 kV			
(15 to 50) Hz	0.31 mV/V + 16 mV		
50 Hz to 1 kHz	67 $\mu\text{V/V}$ + 4 mV		



Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source	(0.22 to 1) kV (1 to 20) kHz (20 to 30) kHz (220 to 750) V (30 to 50) kHz (50 to 100) kHz	13 mV/V + 6 mV 0.49 mV/V + 11 mV 0.47 mV/V + 11 mV 1.8 mV/V + 45 mV	Fluke 5700A Multiproduct Calibrator / 5725A Amplifier
AC Voltage – Measure	(0 to 200) mV (1 to 10) Hz (10 to 40) Hz (40 to 100) Hz (0.1 to 2) kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (0.2 to 2) V (1 to 10) Hz (10 to 40) Hz (40 to 100) Hz (0.1 to 2) kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz (2 to 20) V (1 to 10) Hz (10 to 40) Hz (40 to 100) Hz (0.1 to 2) kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz	0.35 mV/V + 14 μV 0.16 mV/V + 4 μV 0.12 mV/V + 4 μV 0.12 mV/V + 2 μV 0.14 mV/V + 4 μV 0.35 mV/V + 8 μV 0.77 mV/V + 20 μV 0.5 mV/V + 0.12 mV 0.12 mV/V + 20 μV 0.11 mV/V + 20 μV 79 μV/V + 20 μV 0.11 mV/V + 20 μV 0.23 mV/V + 40 μV 0.59 mV/V + 0.2 mV 3 mV/V + 2 mV 10 mV/V + 20 mV 0.36 mV/V + 1.2 mV 0.13 mV/V + 0.2 mV 95 μV/V + 0.2 mV 85 μV/V + 0.2 mV 0.11 mV/V + 0.2 mV 0.22 mV/V + 0.4 mV 0.58 mV/V + 2 mV 3 mV/V + 20 mV 10 mV/V + 0.2 V	Fluke 8508A Multimeter

Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Measure	(20 to 200) V (1 to 10) Hz (10 to 40) Hz (40 to 100) Hz (0.1 to 2) kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz	0.43 mV/V + 12 mV 0.13 mV/V + 2 mV 98 μV/V + 2 mV 83 μV/V + 2 mV 0.12 mV/V + 2 mV 0.22 mV/V + 4 mV 0.58 mV/V + 20 mV 1.6 mV/V + 0.2 V 5.2 mV/V + 2 V	Fluke 8508A Multimeter
	(200 to 1000) V (1 to 10) Hz (10 to 40) Hz 40 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.5 mV/V + 10 mV 0.13 mV/V + 20 mV 0.16 mV/V + 20 mV 0.38 mV/V + 40 mV 0.66 mV/V + 0.2 V	
	(1 to 10) kV	0.16 % of reading	Vitretek 4700 High Voltage Meter
AC Current - Source	(1 to 220) μA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (0.22 to 2.2) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (2.2 to 22) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.66 mA/A + 16 nA 0.329mA/A + 10 nA 0.14 mA/A + 8 nA 0.47 mA/A + 12 nA 1.2 mA/A + 65 nA 0.64 mA/A + 40 nA 0.3 mA/A + 35 nA 0.17 mA/A + 35 nA 0.48 mA/A + 0.11 μA 1.2 mA/A + 0.65 μA 0.6 mA/A + 0.4 μA 0.29 mA/A + 0.35 μA 0.14 mA/A + 0.35 μA 0.47 mA/A + 0.55 μA 1.2 mA/A + 5 μA	Fluke 5700A Multiproduct Calibrator

Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current - Source	(22 to 220) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.6 mA/A + 4 μ A 0.29 mA/A + 3.5 μ A 0.14 mA/A + 2.5 μ A 0.47 mA/A + 3.5 μ A 1.2 mA/A + 10 μ A	Fluke 5700A Multiproduct Calibrator
	(0.22 to 2.2) A 20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.52 mA/A + 35 μ A 0.58 mA/A + 80 μ A 6.6 mA/A + 0.16 mA	
	(2.2 to 11) A (45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.4 mA/A + 0.17 mA 0.76 mA/A + 0.38 mA 2.9 mA/A + 0.75 mA	
	(11 to 20.5) A (45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.96 mA/A + 3.9 mA 1.2 mA/A + 3.9 mA 23 mA/A + 3.9 mA	Fluke 5522A/SC1100 Multiproduct Calibrator
AC Current - Measure	(9 to 200) μ A (1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.58 mA/A + 20 nA 0.52 mA/A + 20 nA 0.65 mA/A + 20 nA 3.1 mA/A + 20 nA	Fluke 8508A Multimeter
	(0.2 to 2) mA (1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.42 mA/A + 0.2 μ A 0.31 mA/A + 0.2 μ A 0.63 mA/A + 0.2 μ A 3.1 mA/A + 0.2 μ A	
	(2 to 20) mA (1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.41 mA/A + 2 μ A 0.31 mA/A + 2 μ A 0.63 mA/A + 2 μ A 3.7 mA/A + 2 μ A	
	(20 to 200) mA (1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz	0.42 mA/A + 20 μ A 0.3 mA/A + 20 μ A 0.68 mA/A + 20 μ A	



Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current - Measure	(0.2 to 2) A (1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (2 to 20) A 10 Hz to 2 kHz (2 to 10) kHz	0.57 mA/A + 0.2 mA 0.85 mA/A + 0.2 mA 2.4 mA/A + 0.2 mA 0.74 mA/A + 0.2 mA 2.1 mA/A + 0.2 mA	Fluke 8508A Multimeter
Capacitance – Source 10 Hz to 10 kHz 10 Hz to 3 kHz (0.01 to 1) kHz (0.01 to 1) kHz (0.01 to 1) kHz (10 to 600) Hz (10 to 300) Hz (10 to 150) Hz (10 to 120) Hz (10 to 80) Hz (10 to 50) Hz (10 to 20) Hz Up to 6 Hz Up to 2 Hz Up to 0.6 Hz Up to 0.2 Hz	(0.19 to 1.1) nF (1.1 to 3.3) nF (3.3 to 11) nF (11 to 110) nF (110 to 330) nF (0.33 to 1.1) μF (1.1 to 3.3) μF (3.3 to 11) μF (11 to 33) μF (33 to 110) μF (110 to 330) μF (0.33 to 1.1) mF (1.1 to 3.3) mF (3.3 to 11) mF (11 to 33) mF (33 to 110) mF	5 pF/nF + 7.8 pF 4 pF/nF + 7.8 pF 2 pF/nF + 7.8 pF 7 pF/nF + 78 pF 2.1 pF/nF + 0.23 nF 2.1 nF/μF + 0.78 nF 2 nF/μF + 2.3 nF 2.1 nF/μF + 7.8 nF 3.2 nF/μF + 23 nF 3.7 nF/μF + 78 nF 3.7 nF/μF + 0.23μF 3.7 μF/mF + 0.78 μF 3.7 μF/mF + 2.3 μF 3.5 μF/mF + 7.8 μF 5.9 μF/mF + 23 μF 8.5 μF/mF + 78 μF	Fluke 5522A/SC1100 Multiproduct Calibrator
Oscilloscopes Square Wave 50 Ω Load 1 MΩ Load Leveled Sine Wave Relative to 50 kHz	±1 mV to ±6.6 V p-p 10 Hz to 10 kHz ±1 mV to ±130 V p-p 10 Hz to 10 kHz 5 mVpp to 5.5 Vpp 50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz 5 mVpp to 3.5 Vpp 600 Hz to 1100 MHz	2.7 mV/V + 32 μV 1.3 mV/V + 32 μV 15 mV/V + 78 μV 18 mV/V + 78 μV 34 mV/V + 78 μV 42 mV/V + 78 μV	Fluke 5522A/SC1100 Multiproduct Calibrator



Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Oscilloscopes Time Marker Into 50 Ω Load	Cardinal Points 1 ns to 20 ms Non-Cardinal Points 1 ns to 20 ms Any value in range 50 ms to 5 s	46 ns/s 0.81 μs/s 0.21 ms/s	Fluke 5522A/SC1100 Multiproduct Calibrator
Rise Time	300 ps	9.4 ps	
Electrical Simulation of Thermocouple Indicators	Type B (600 to 800) °C (800 to 1 000) °C (1 000 to 1 550) °C (1 550 to 1 820) °C Type C (0 to 150) °C (150 to 650) °C (650 to 1 000) °C (1 000 to 1 800) °C (1 800 to 2 316) °C Type E (-250 to -100) °C (-100 to -25) °C (-25 to 350) °C (350 to 650) °C (650 to 1 000) °C Type J (-210 to -100) °C (-100 to -30) °C (-30 to 150) °C (150 to 760) °C (760 to 1 200) °C Type K (-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 1 000) °C (1 000 to 1 372) °C	0.46 °C 0.39 °C 0.37 °C 0.38 °C 0.33 °C 0.32 °C 0.34 °C 0.54 °C 0.85 °C 0.52 °C 0.22 °C -0.2 °C 0.25 °C 0.25 °C 0.33 °C 0.22 °C 0.2 °C 0.23 °C 0.27 °C 0.36 °C 0.23 °C 0.22 °C 0.29 °C 0.44 °C	Fluke 5522A/SC1100 Multiproduct Calibrator



Electrical – DC Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Electrical Simulation of Thermocouple Indicators	Type N		Fluke 5522A/SC1100 Multiproduct Calibrator
	(-200 to -100) °C	0.43 °C	
	(-100 to -25) °C	0.29 °C	
	(-25 to 120) °C	0.23 °C	
	(120 to 410) °C	0.22 °C	
	(410 to 1 300) °C	0.3 °C	
	Type R		
	(0 to 250) °C	0.59 °C	
	(250 to 400) °C	0.38 °C	
	(400 to 1 000) °C	0.36 °C	
	(1 000 to 1 767) °C	0.44 °C	
	Type S		
	(0 to 250) °C	0.49 °C	
	(250 to 1 000) °C	0.39 °C	
	(1 000 to 1 400) °C	0.39 °C	
	(1 400 to 1 767) °C	0.5 °C	
	Type T		
(-250 to -150) °C	0.65 °C		
(-150 to 0) °C	0.26 °C		
(0 to 120) °C	0.22 °C		
(120 to 400) °C	0.19 °C		
Type U			
(-200 to 0) °C	-0.6 °C		
(0 to 600) °C	0.31 °C		
Electrical Simulation of RTD Indicators	Pt 395 (100 Ω)		Fluke 5522A/SC1100 Multiproduct Calibrator
	(-200 to -80) °C	0.07 °C	
	(-80 to 0) °C	0.07 °C	
	(0 to 100) °C	0.08 °C	
	(100 to 300) °C	0.11 °C	
	(300 to 400) °C	0.11 °C	
	(400 to 630) °C	0.13 °C	
	(630 to 800) °C	0.25 °C	
	Pt 3926 (100 Ω)		
	(-200 to -80) °C	0.1 °C	
	(-80 to 0) °C	0.1 °C	
	(0 to 100) °C	0.11 °C	
	(100 to 300) °C	0.13 °C	
	(300 to 400) °C	0.16 °C	
(400 to 630) °C	0.15 °C		



Electrical Simulation of RTD Indicators	Pt 3916 (100 Ω)		
	(-200 to -190) °C		0.28 °C
	(-190 to -80) °C		0.09 °C
	(-80 to 0) °C		0.11 °C
	(0 to 100) °C		0.12 °C
	(100 to 260) °C		0.1 °C
	(260 to 300) °C		0.14 °C
	(300 to 400) °C		0.15 °C
	(400 to 600) °C		0.14 °C
	(600 to 630) °C		0.26 °C
	Pt 385 (200 Ω)		
	(-200 to -80) °C		0.06 °C
	(-80 to 0) °C		0.11 °C
	(0 to 100) °C		0.11 °C
	(100 to 260) °C		0.12 °C
	(260 to 300) °C		0.16 °C
	(300 to 400) °C		0.15 °C
	(400 to 600) °C		0.16 °C
	(600 to 630) °C		0.17 °C
	Pt 385 (500 Ω)		
	(-200 to -80) °C		0.06 °C
	(-80 to 0) °C		0.09 °C
	(0 to 100) °C		0.1 °C
	(100 to 260) °C		0.09 °C
	(260 to 300) °C		0.12 °C
	(300 to 400) °C		0.09 °C
	(400 to 600) °C		0.1 °C
	(600 to 630) °C		0.14 °C
	Pt 385 (1 000 Ω)		
	(-200 to -80) °C		0.05 °C
(-80 to 0) °C		0.09 °C	
(0 to 100) °C		0.06 °C	
(100 to 260) °C		0.12 °C	
(260 to 300) °C		0.07 °C	
(300 to 400) °C		0.1 °C	
(400 to 600) °C		0.11 °C	
(600 to 630) °C		0.25 °C	
PtNi 385 (120 Ω)			
(-80 to 0) °C		0.13 °C	
(0 to 100) °C		0.1 °C	
(100 to 260) °C		0.17 °C	
Cu 427 (10 Ω)			
(-100 to 260) °C		0.31 °C	
			Fluke 5522A/SC1100 Multiproduct Calibrator



Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
RF Attenuation – Tuned RF Power Measure 100 kHz to 26.5 GHz	(0.0 to -10) dB (-10 to -20) dB (-20 to -30) dB (-30 to -40) dB (-40 to -50) dB (-50 to -60) dB (-60 to -70) dB (-70 to -80) dB (-80 to -90) dB (-90 to -100) dB (-100 to -110) dB (-110 to -120) dB	0.03 dB 0.06 dB 0.08 dB 0.11 dB 0.14 dB 0.16 dB 0.2 dB 0.23 dB 0.25 dB 0.27 dB 0.35 dB 0.43 dB	HP 8902A Measuring Receiver with HP 11722A, HP 11792A, HP 11793A Power Sensors
RF Power - Source DC to 10 MHz 10 MHz to 2 GHz (2 to 20) GHz (20 to 40) GHz (40 to 50) GHz	(+23.98 to -56.00) dBm (+13 to -110) dBm	0.69 dB 2.1 dB 2.2 dB 2.6 dB 3.8 dB	HP 3325B, HP 83630B Signal Generators
RF Power – Measure	(+20 to -30) dBm DC to 50 GHz	3.9% of reading + 0.004 dB	HP 8902A Measuring Receiver with HP 11722A, HP 11792A, HP 8487A Power Sensors
Power Reference Out	1 mW, 50 MHz	2.1 % of reading	HP 432A Power Meter, HP 3458A Multimeter, with HP 8478A Power Sensor
Phase Modulation – Measure 150 kHz to 10 MHz 10 MHz to 26.5 GHz	200 Hz to 10 kHz 200 Hz to 20 kHz	4.8 % of reading + 1 Digit 3.7 % of reading + 1 Digit	HP 8902A Measuring Receiver with HP 11722A, HP 11792A, HP 11793A Power Sensors



Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Amplitude Modulation – Measure	150 kHz to 10 MHz Rate: 50 Hz to 10 kHz Depths: 5 % to 99 %	3.5 % of reading + 1 Digit	HP 8902A Measuring Receiver with HP 11722A, HP 11792A, HP 11793A Power Sensors
	150 kHz to 10 MHz Rate: 20 Hz to 10 kHz Depths: to 99 %	2.3 % of reading + 1 Digit	
	10 MHz to 1.3 GHz Rate: 50 Hz to 50 kHz Depths: 5 % to 99 %	3.5 % of reading + 1 Digit	
	10 MHz to 1.3 GHz Rate: 20 Hz to 100 kHz Depths: to 99 %	1.2 % of reading + 1 Digit	
	(1.3 to 26.5) GHz Rate: 20 Hz to 100 kHz Depths: 5 % to 99 %	3.5 % of reading + 1 Digit	
	(1.3 to 26.5) GHz Rate: 20 Hz to 100 kHz Depths: to 99 %	1.7 % of reading + 1 Digit	
Frequency Modulation – Measure	250 kHz to 10 MHz Rate: 20 Hz to 10 kHz Dev.: ≤ 40 kHz peak	2.3 % of reading + 1 Digit	HP 8902A Measuring Receiver with HP 11722A, HP 11792A, HP 11793A Power Sensors
	10 MHz to 1.3 GHz Rate: 50 Hz to 100 kHz Dev.: ≤ 400 kHz peak	5.8 % of reading + 1 Digit	
	10 MHz to 1.3 GHz Rate: 20 Hz to 200 kHz Dev.: ≤ 400 kHz peak	1.2 % of reading + 1 Digit	
	(1.3 to 26.5) GHz Rate: 50 Hz to 100 kHz Dev.: ≤ 400 kHz peak	5.8 % of reading + 1 Digit	
	(1.3 to 26.5) GHz Rate: 20 Hz to 200 kHz Dev.: ≤ 400 kHz peak	1.2 % of reading + 1 Digit	



Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Micrometers ²	Up to 10 in	(3.9 +1.1L) μin	Grade 2 Gage Blocks
Calipers ²	Up to 10 in	(3.9 +1.1L) μin	
Height/Depth Gages ²	Up to 10 in	(3.9 +1.1L) μin	
Indicators ²	Up to 4 in	(3.9 +1.1L) μin	

Mass and Mass Related

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Scales and Balances	Up to 5 g (5 to 20) g (20 to 100) g 100 g to 1 kg	2.3 mg 3.5 mg 12 mg 120 mg	ASTM 6 Weights
Pressure	(0 to 200) psi (0 to 500) psi (0 to 1 000) psi	1.2 psi 0.88 psi 2.1 psi	Condec UPC5000 Pressure Standard
Torque	4 lbf·in to 600 lbf·ft	0.31 % of reading	CDI 5000-ST Torque Monitor with CDI 2000-400-02, CDI 2000-12-02 Torque Cells

Thermodynamics

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Relative Humidity	30 %RH 50 %RH 80 %RH	1.7 %RH	Vaisala HMI41 and HMP46 Humidity Indicator, Calibration Salt

Time and Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Time Interval	1 s to 3 hours	38 ms	HP 53132A Counter
Frequency – Source	10 MHz DC to 20 MHz 20 MHz to 50 GHz	7.5 mHz 58 mHz 0.88 Hz	SRS FS725 Frequency Standard, HP 3325B, HP 83650B Signal Generators
Frequency – Measure	DC to 225 MHz 225 MHz to 46 GHz	0.0074 Hz 0.59 Hz	HP 53132A with SRS FS725, HP 53152A with SRS FS725

Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 ($k=2$), corresponding to a confidence level of approximately 95%.

Notes:

1. On-site calibration service is available for this parameter, since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope.
2. L = length in inches
3. This scope is formatted as part of a single document including Certificate of Accreditation No. AC-1986.



Vice President

